



Support & training



SN65176B, SN75176B SLLS101G – JULY 1985 – REVISED JULY 2021

# SNx5176B Differential Bus Transceivers

## 1 Features

- Bidirectional transceivers
- Meet or exceed the requirements of ANSI standards TIA/EIA-422-B and TIA/EIA-485-A and ITU Recommendations V.11 and X.27
- Designed for multipoint transmission on long bus lines in noisy environments
- 3-State driver and receiver outputs
- Individual driver and receiver enables
- Wide positive and negative input/output bus voltage ranges
- ± 60-mA Maximum driver output capability
- Thermal shutdown protection
- Driver positive and negative current limiting
- 12-kΩ Minimum Receiver Input Impedance
- ± 200-mV Receiver input sensitivity
- 50-mV Typical receiver input hysteresis
- Operate from single 5-V supply

## 2 Applications

- Chemical and gas sensors
- Digital signage
- HMI (human machine interfaces)
- Motor controls: AC induction, brushed and brushless dc, low- and high-voltage, stepper motors, and permanent magnets
- TETRA Base stations
- Telecom towers: remote electrical tilt units (ret) and tower mounted amplifiers (TMA)
- Weigh scales
- · Wireless repeaters

## **3 Description**

The SN65176B and SN75176B differential bus transceivers are designed for bidirectional data communication on multipoint bus transmission lines. They are designed for balanced transmission lines and meet ANSI Standards TIA/EIA-422-B and TIA/EIA-485-A and ITU Recommendations V.11 and X.27.

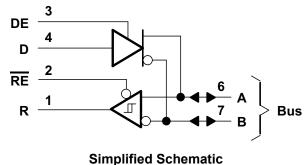
The SN65176B and SN75176B devices combine a 3-state differential line driver and a differential input line receiver, both of which operate from a single 5-V power supply. The driver and receiver have active-high and active-low enables, respectively, that can be connected together externally to function as a direction control. The driver differential outputs and the receiver differential input/output (I/O) bus ports that are designed to offer minimum loading to the bus when the driver is disabled or  $V_{CC} = 0$ . These ports feature wide positive and negative common-mode voltage ranges, making the device suitable for party-line applications.

The driver is designed for up to 60 mA of sink or source current. The driver features positive and negative current limiting and thermal shutdown for protection from line-fault conditions. Thermal shutdown is designed to occur at a junction temperature of approximately 150°C. The receiver features a minimum input impedance of 12 k $\Omega$ , an input sensitivity of ±200 mV, and a typical input hysteresis of 50 mV.

**Device Information** 

| PART NUMBER | PACKAGE (PIN) <sup>(1)</sup> | BODY SIZE (NOM)   |
|-------------|------------------------------|-------------------|
|             | SOIC (8)                     | 4.90 mm × 3.91 mm |
| SNx5176     | PDIP (8)                     | 9.81 mm × 6.35 mm |
|             | SOP (8)                      | 6.20 mm × 5.30 mm |

(1) For all available packages, see the orderable addendum at the end of the datasheet.





## **Table of Contents**

| 1 Features1                                |
|--|
| 2 Applications1                            |
| 3 Description1                             |
| 4 Revision History                         |
| 5 Pin Configuration and Functions          |
| 6 Specifications                           |
| 6.1 Absolute Maximum Ratings4              |
| 6.2 Recommended Operating Conditions4      |
| 6.3 Thermal Information4                   |
| 6.4 Electrical Characteristics – Driver5   |
| 6.5 Electrical Characteristics – Receiver6 |
| 6.6 Switching Characteristics – Driver6    |
| 6.7 Switching Characteristics – Receiver6  |
| 6.8 Typical Characteristics7               |
| Parameter Measurement Information          |
| 7 Detailed Description12                   |
| 7.1 Overview12                             |
| 7.2 Functional Block Diagram12             |

| 7.3 Feature Description                 | 12 |
|---|----|
| 7.4 Device Functional Modes             |    |
| 8 Application and Implementation        | 14 |
| 8.1 Application Information             |    |
| 8.2 Typical Application                 | 14 |
| 8.3 System Examples                     | 15 |
| 9 Power Supply Recommendations          | 16 |
| 10 Layout                               | 16 |
| 10.1 Layout Guidelines                  |    |
| 10.2 Layout Example                     |    |
| 11 Device and Documentation Support     | 17 |
| 11.1 Related Links                      | 17 |
| 11.2 Trademarks                         |    |
| 11.3 Electrostatic Discharge Caution    | 17 |
| 11.4 Glossary                           |    |
| 12 Mechanical, Packaging, and Orderable |    |
| Information                             |    |
|   |    |

# **4 Revision History**

| CI | hanges from Revision F (January 2015) to Revision G (July 2021)   | Page           |
|----|---|----------------|
| •  | Changed the Thermal Information table   | 4              |
| •  | Changed the Vo Output voltage MAX value from: 6 V to: VCC in the Electrical Characteristics - Driver                              | <mark>5</mark> |
| •  | Changed the V <sub>ODI</sub> Differential output voltage MAX value from: 6 V to: V <sub>CC</sub> in the Electrical Characteristic | cs –           |
|    | Driver  | <mark>5</mark> |
|    |   |                |

#### Changes from Revision E (January 2014) to Revision F (January 2015)

| C | hanges from Revision E (January 2014) to Revision F (January 2015)                                     | Page     |
|---|--|----------|
| • | Added Applications, Device Information table, Pin Functions table, ESD Ratings table, Thermal Informa  | tion     |
|   | table, Feature Description section, Device Functional Modes, Application and Implementation section, F | Power    |
|   | Supply Recommendations section, Layout section, Device and Documentation Support section, and          |          |
|   | Mechanical, Packaging, and Orderable Information section   | 1        |
| • | Moved Typical Characteristics inside of the Specifications section                                     | <b>7</b> |

| C | hanges from Revision D (April 2003) to Revision E (January 2014)        | Page |
|---|---|------|
| • | Updated document to new TI data sheet format - no specification changes | 1    |
| • | Deleted Ordering Information table                                      | 1    |



## **5** Pin Configuration and Functions

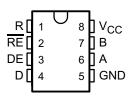


Figure 5-1. Top View

#### Table 5-1. Pin Functions

| PIN   |   | ТҮРЕ                                      | DESCRIPTION                            |  |
|---|---|---|--|--|
| NAME NO.  |   |   |  |  |
| R   | 1 | 0   | Logic Data Output from RS-485 Receiver |  |
| RE  | 2 | I   | Receive Enable (active low)            |  |
| DE  | 3 | I   | r Enable (active high)                 |  |
| D   | 4 | I   | ic Data Input to RS-485 Driver         |  |
| GND   | 5 | _   | vice Ground Pin                        |  |
| A   | 6 | I/O                                       | 422 or RS-485 Data Line                |  |
| В   | 7 | I/O                                       | 422 or RS-485 Data Line                |  |
| V <sub>CC</sub> 8 — Power Input. Connect to 5-V Power Source. |   | Power Input. Connect to 5-V Power Source. |  |  |



## **6** Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                  |  | MIN | MAX | UNIT |
|------------------|--|-----|-----|------|
| V <sub>CC</sub>  | Supply voltage <sup>(2)</sup>                                |     | 7   | V    |
|                  | Voltage range at any bus terminal                            | -10 | 15  | V    |
| VI               | Enable input voltage   |     | 5.5 | V    |
| TJ               | Operating virtual junction temperature                       |     | 150 | °C   |
| T <sub>stg</sub> | Storage temperature range                                    | -65 | 150 | °C   |
|                  | Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds |     | 260 | °C   |

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Section 6.2 is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values, except differential input/output bus voltage, are with respect to network ground terminal.

## **6.2 Recommended Operating Conditions**

|                     |   |                 | MIN  | TYP | MAX  | UNIT |
|---------------------|---|-----------------|------|-----|------|------|
| V <sub>CC</sub>     | Supply voltage                            |                 | 4.75 | 5   | 5.25 | V    |
| $V_{I}$ or $V_{IC}$ | Voltage at any bus terminal (separately   | or common mode) | -7   |     | 12   | V    |
| V <sub>IH</sub>     | High-level input voltage                  | D, DE, and RE   | 2    |     |      | V    |
| V <sub>IL</sub>     | Low-level input voltage                   | D, DE, and RE   |      |     | 0.8  | V    |
| V <sub>ID</sub>     | Differential input voltage <sup>(1)</sup> |                 |      |     | ±12  | V    |
| 1                   | High-level output current                 | Driver          |      |     | -60  | mA   |
| IOH                 |   | Receiver        |      |     | -400 | μA   |
|                     |   | Driver          |      |     | 60   | m۸   |
| IOL                 | Low-level output current                  | Receiver        |      |     | 8    | mA   |
| т                   |   | SN65176B        | -40  |     | 105  | 5 °C |
| IA                  | Operating free-air temperature            | SN75176B        | 0    |     | 70   | C    |

(1) Differential input/output bus voltage is measured at the non-inverting terminal A, with respect to the inverting terminal B.

#### **6.3 Thermal Information**

|                       | THERMAL METRIC <sup>(1)</sup>                | D (SOIC) | PS (SO) | P (PDIP) | UNIT |
|-----------------------|--|----------|---------|----------|------|
|                       |  |          | 8 PINS  | •        |      |
| R <sub>0JA</sub>      | Junction-to-ambient thermal resistance       | 114.4    | 113.2   | 88.1     | °C/W |
| R <sub>0JC(top)</sub> | Junction-to-case (top) thermal resistance    | 55.1     | 57.9    | 65.9     | °C/W |
| $R_{\theta JB}$       | Junction-to-board thermal resistance         | 61.6     | 69.0    | 69.0     | °C/W |
| Ψյτ                   | Junction-to-top characterization parameter   | 78.8     | 14.6    | 35.2     | °C/W |
| Ψ <sub>JB</sub>       | Junction-to-board characterization parameter | 60.8     | 68.1    | 64.3     | °C/W |

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).



### 6.4 Electrical Characteristics – Driver

|                  | I was a set as used | www.alterne.end.energetim | a fus a sin tanan anatuma | (unless otherwise noted) |
|------------------|---------------------|---------------------------|---------------------------|--------------------------|
| over recommended | i rannes ni sunni   | v vollane and operalin    | n iree-air iemnerailire   |                          |
|                  | runges or suppr     | y vonage and operatin     | g noo-an temperature      |                          |

| PARAMETER         |  | TEST CONDITIONS <sup>(1)</sup>        |                                | MIN  | TYP <sup>(2)</sup> | MAX  | UNIT |    |
|-------------------|--|---------------------------------------|--------------------------------|--|--------------------|------|------|----|
| V <sub>IK</sub>   | Input clamp voltage  | I <sub>I</sub> = -18 mA               |                                |  |                    | -1.5 | V    |    |
| Vo                | Output voltage   | I <sub>O</sub> = 0                    |                                | 0  |                    | Vcc  | V    |    |
| V <sub>OD1</sub>  | Differential output voltage  | I <sub>O</sub> = 0                    |                                | 1.5  | 3.6                | Vcc  | V    |    |
|                   | Differential output voltage  | $R_L = 100 \Omega$ , see Figur        | re 7-1                         | $^{1}\!$ |                    |      | V    |    |
| V <sub>OD2</sub>  | Dillerential output voltage  | $R_L = 54 \Omega$ , see Figure        | 7-1                            | 1.5  | 2.5                | 5    | v    |    |
| V <sub>OD3</sub>  | Differential output voltage  | See <sup>(5)</sup>                    |                                | 1.5  |                    | 5    | V    |    |
| $\Delta  V_{OD} $ | Change in magnitude of differential output voltage <sup>(3)</sup>      | R <sub>L</sub> = 54 Ω or 100 Ω, s     | ee Figure 7-1                  |  |                    | ±0.2 | V    |    |
| V <sub>OC</sub>   | Common-mode output voltage   | $R_L$ = 54 Ω or 100 Ω, s              | ee Figure 7-1                  | -1   |                    | +3   | V    |    |
| ∆ V <sub>OC</sub> | Change in magnitude<br>of common-mode output<br>voltage <sup>(3)</sup> | $R_L$ = 54 Ω or 100 Ω, see Figure 7-1 |                                |  |                    | ±0.2 | V    |    |
|                   | Output current   |                                       | Output disabled <sup>(6)</sup> | V <sub>O</sub> = 12 V  |                    |      | 1    | mA |
| I <sub>O</sub>    |  |                                       | V <sub>O</sub> = -7 V          |  |                    | -0.8 | 3    |    |
| I <sub>IH</sub>   | High-level input current   | V <sub>1</sub> = 2.4 V                |                                |  |                    | 20   | μA   |    |
| I <sub>IL</sub>   | Low-level input current  | V <sub>1</sub> = 0.4 V                |                                |  |                    | -400 | μA   |    |
|                   |  | V <sub>0</sub> = -7 V                 |                                |  |                    | -250 |      |    |
|                   | Short-circuit output current   | V <sub>O</sub> = 0                    |                                |  |                    | -150 | mA   |    |
| I <sub>OS</sub>   | Shon-circuit output current  | $V_0 = V_{CC}$                        |                                |  |                    | 250  | ШA   |    |
|                   |  | V <sub>0</sub> = 12 V                 |                                |  |                    | 250  |      |    |
| 1                 | Supply ourrant (total package)   | Outputs enabled                       |                                | 42   | 70                 |      |      |    |
| I <sub>CC</sub>   | Supply current (total package)   | No load                               | Outputs disabled               |  | 26                 | 35   | mA   |    |

(1) The power-off measurement in ANSI Standard TIA/EIA-422-B applies to disabled outputs only and is not applied to combined inputs and outputs.

(2) All typical values are at  $V_{CC} = 5 \text{ V}$  and  $T_A = 25^{\circ}\text{C}$ .

(3)  $\Delta |V_{OD}|$  and  $\Delta |V_{OC}|$  are the changes in magnitude of  $V_{OD}$  and  $V_{OC}$ , respectively, that occur when the input is changed from a high level to a low level.

The minimum  $V_{OD2}$  with a 100- $\Omega$  load is either  $\frac{1}{2} V_{OD1}$  or 2 V, whichever is greater. See ANSI Standard TIA/EIA-485-A, Figure 3.5, Test Termination Measurement 2. (4)

(5)

This applies for both power on and off; refer to ANSI Standard TIA/EIA-485-A for exact conditions. The TIA/EIA-422-B limit does not (6) apply for a combined driver and receiver terminal.



## 6.5 Electrical Characteristics – Receiver

over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature (unless otherwise noted)

|                  | PARAMETER   | TEST CON  | MIN   | TYP <sup>(1)</sup> | MAX  | UNIT |    |
|------------------|---|---|---|--------------------|------|------|----|
| V <sub>IT+</sub> | Positive-going input threshold voltage                          | V <sub>O</sub> = 2.7 V, I <sub>O</sub> = -0.4 mA      |   |                    | 0.2  | V    |    |
| V <sub>IT-</sub> | Negative-going input threshold voltage                          | V <sub>O</sub> = 0.5 V, I <sub>O</sub> = 8 mA         | V <sub>O</sub> = 0.5 V, I <sub>O</sub> = 8 mA |                    |      |      |    |
| V <sub>hys</sub> | Input hysteresis voltage (V <sub>IT+</sub> – V <sub>IT</sub> –) |   |   |                    | 50   |      | mV |
| VIK              | Enable Input clamp voltage                                      | I <sub>I</sub> = –18 mA                               |   |                    |      | -1.5 | V  |
| V <sub>OH</sub>  | High-level output voltage                                       | V <sub>ID</sub> = 200 mV, I <sub>OH</sub> = -400 μA,  | 2.7   |                    |      | V    |    |
| V <sub>OL</sub>  | Low-level output voltage  | V <sub>ID</sub> = –200 mV, I <sub>OL</sub> = 8 mA, se |   |                    | 0.45 | V    |    |
| I <sub>OZ</sub>  | High-impedance-state output current                             | V <sub>O</sub> = 0.4 V to 2.4 V                       |   |                    | ±20  | μA   |    |
|                  |   | Other input = 0.1(3)                                  | V <sub>I</sub> = 12 V                         |                    |      | 1    |    |
| li               | Line input current  | Other input = 0 V <sup>(3)</sup> $V_1 = -7 V$         |   |                    |      | -0.8 | mA |
| IIH              | High-level enable input current                                 | V <sub>IH</sub> = 2.7 V                               |   |                    |      | 20   | μA |
| IIL              | Low-level enable input current                                  | V <sub>IL</sub> = 0.4 V                               |   |                    |      | -100 | μA |
| rı               | Input resistance  | V <sub>I</sub> = 12 V                                 | V <sub>I</sub> = 12 V                         |                    |      |      | kΩ |
| Ios              | Short-circuit output current                                    |   |   | -15                |      | -85  | mA |
|                  |   | Nalaad  | Outputs enabled                               |                    | 42   | 55   |    |
| ICC              | Supply current (total package)                                  | No load Outputs disabled                              |   |                    | 26   | 35   | mA |

(1) All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C.

(2) The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet for common-mode input voltage and threshold voltage levels only.

(3) This applies for both power on and power off. Refer to EIA Standard TIA/EIA-485-A for exact conditions.

#### 6.6 Switching Characteristics – Driver

 $V_{CC} = 5 \text{ V}, \text{ R}_{\text{I}} = 110 \Omega, \text{ T}_{\text{A}} = 25^{\circ}\text{C}$  (unless otherwise noted)

|                    | PARAMETER                           | TEST CONDITIONS                    | MIN | TYP | MAX | UNIT |
|--------------------|-------------------------------------|------------------------------------|-----|-----|-----|------|
| t <sub>d(OD)</sub> | Differential-output delay time      | $R_L = 54 \Omega$ , see Figure 7-3 |     | 15  | 22  | ns   |
| t <sub>t(OD)</sub> | Differential-output transition time | $R_L = 54 \Omega$ , see Figure 7-3 |     | 20  | 30  | ns   |
| t <sub>PZH</sub>   | Output enable time to high level    | See Figure 7-4                     |     | 85  | 120 | ns   |
| t <sub>PZL</sub>   | Output enable time to low level     | See Figure 7-5                     |     | 40  | 60  | ns   |
| t <sub>PHZ</sub>   | Output disable time from high level | See Figure 7-4                     |     | 150 | 250 | ns   |
| t <sub>PLZ</sub>   | Output disable time from low level  | See Figure 7-5                     |     | 20  | 30  | ns   |

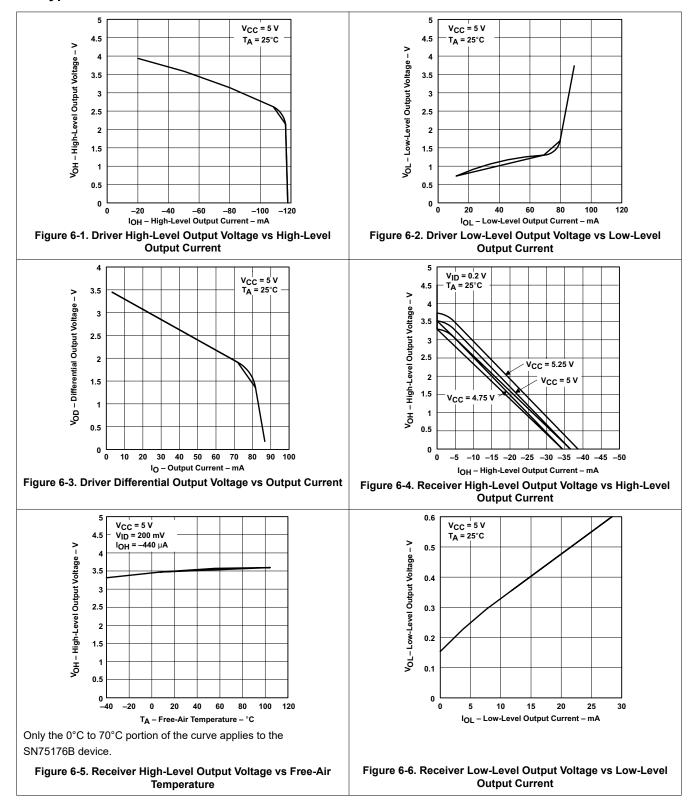
#### 6.7 Switching Characteristics – Receiver

 $V_{CC} = 5 V, C_{L} = 15 pF, T_{A} = 25^{\circ}C$ 

|                  | PARAMETER   | TEST CONDITIONS   | MIN | TYP | MAX | UNIT |
|------------------|---|---|-----|-----|-----|------|
| t <sub>PLH</sub> | Propagation delay time, low- to high-level output | $V_{ID} = 0$ to 3 V, see Figure 7-6                       |     | 21  | 35  | 20   |
| t <sub>PHL</sub> | Propagation delay time, high- to low-level output | $v_{\text{ID}} = 0.003 \text{ v}, \text{ see Figure 7-0}$ |     | 23  | 35  | ns   |
| t <sub>PZH</sub> | Output enable time to high level                  | See Figure 7-7  |     | 10  | 20  | 20   |
| t <sub>PZL</sub> | Output enable time to low level                   |   |     | 12  | 20  | ns   |
| t <sub>PHZ</sub> | Output disable time from high level               | See Figure 7-7  |     | 20  | 35  | 20   |
| t <sub>PLZ</sub> | Output disable time from low level                |   |     | 17  | 25  | ns   |

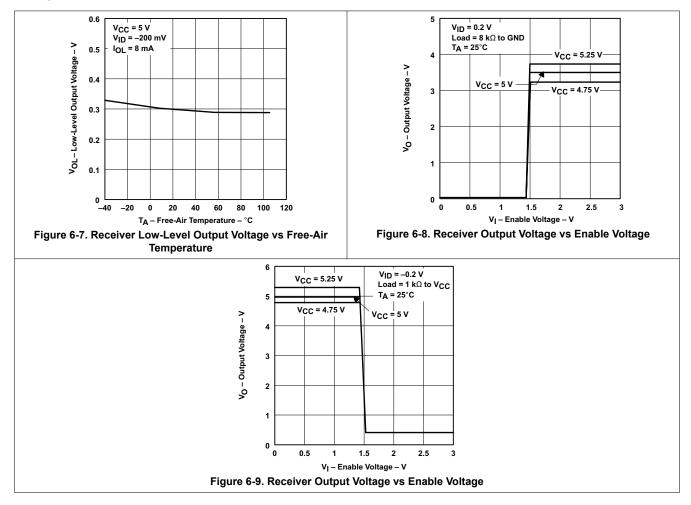


#### **6.8 Typical Characteristics**





#### 6.8 Typical Characteristics (continued)





### **Parameter Measurement Information**

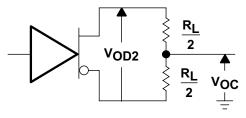


Figure 7-1. Driver  $V_{OD}$  and  $V_{OC}$ 

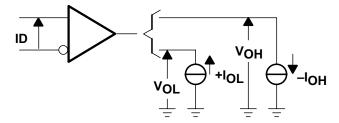
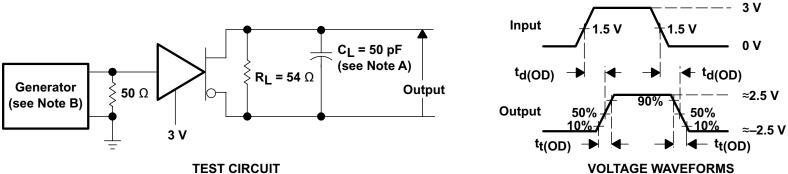


Figure 7-2. Receiver  $V_{OH}$  and  $V_{OL}$ 



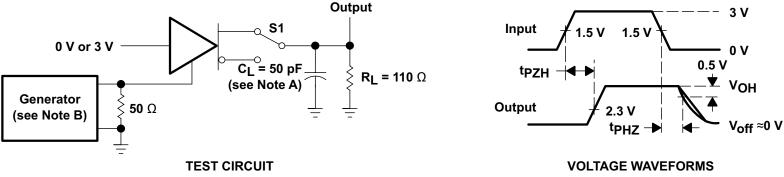
 $C_{L}$  includes probe and jig capacitance.

Α.

Α.

B. The input pulse is supplied by a generator having the following characteristics: PRR ≤1 MHz, 50% duty cycle,  $t_r \le 6$  ns,  $t_f \le 6$  ns,  $Z_O = 50$   $\Omega$ .

#### Figure 7-3. Driver Test Circuit and Voltage Waveforms

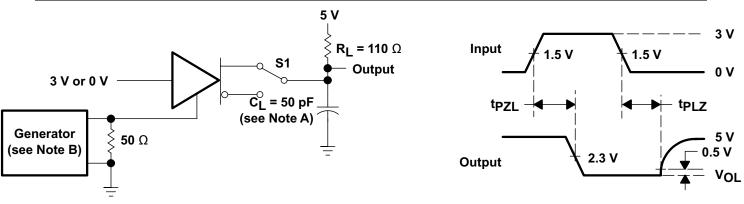


C<sub>L</sub> includes probe and jig capacitance.

B. The input pulse is supplied by a generator having the following characteristics: PRR ≤1 MHz, 50% duty cycle, t<sub>r</sub> ≤ 6 ns, t<sub>f</sub> ≤ 6 ns, Z<sub>0</sub> = 50 Ω.

#### Figure 7-4. Driver Test Circuit and Voltage Waveforms

#### SN65176B, SN75176B SLLS101G – JULY 1985 – REVISED JULY 2021



#### **TEST CIRCUIT**

#### VOLTAGE WAVEFORMS

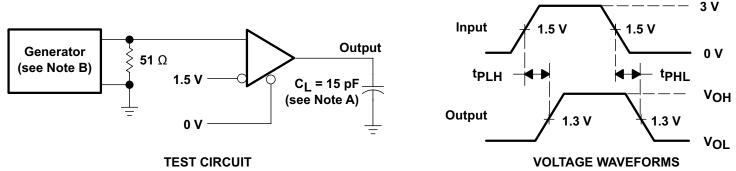
FXAS

STRUMENTS

www.ti.com

A.  $C_L$  includes probe and jig capacitance.

B. The input pulse is supplied by a generator having the following characteristics: PRR ≤1 MHz, 50% duty cycle, t<sub>r</sub> ≤ 6 ns, t<sub>f</sub> ≤ 6 ns, Z<sub>0</sub> = 50 Ω.

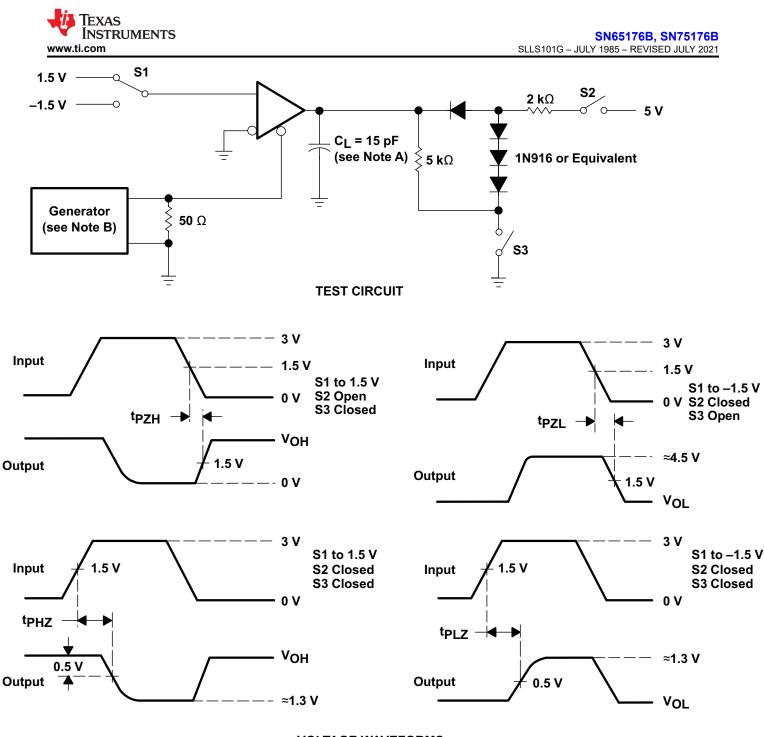


### Figure 7-5. Driver Test Circuit and Voltage Waveforms

A. C<sub>L</sub> includes probe and jig capacitance.

B. The input pulse is supplied by a generator having the following characteristics: PRR ≤1 MHz, 50% duty cycle,  $t_r \le 6$  ns,  $t_f \le 6$  ns,  $Z_O = 50$   $\Omega$ .

## Figure 7-6. Receiver Test Circuit and Voltage Waveforms



VOLTAGE WAVEFORMS

A. C<sub>L</sub> includes probe and jig capacitance.

B. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq 1$  MHz, 50% duty cycle, t<sub>r</sub>  $\leq 6$  ns, t<sub>f</sub>  $\leq 6$  ns, Z<sub>O</sub> = 50  $\Omega$ .





## 7 Detailed Description

## 7.1 Overview

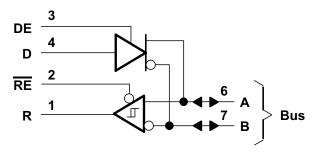
The SN65176B and SN75176B differential bus transceivers are integrated circuits designed for bidirectional data communication on multipoint bus transmission lines. They are designed for balanced transmission lines and meet ANSI Standards TIA/EIA-422-B and TIA/EIA-485-A and ITU Recommendations V.11 and X.27.

The SN65176B and SN75176B devices combine a 3-state differential line driver and a differential input line receiver, both of which operate from a single 5-V power supply. The driver and receiver have active-high and active-low enables, respectively, that can be connected together externally to function as a direction control. The driver differential outputs and the receiver differential inputs are connected internally to form differential input/output (I/O) bus ports that are designed to offer minimum loading to the bus when the driver is disabled or  $V_{CC} = 0$ . These ports feature wide positive and negative common-mode voltage ranges, making the device suitable for party-line applications.

The driver is designed for up to 60 mA of sink or source current. The driver features positive and negative current limiting and thermal shutdown for protection from line-fault conditions. Thermal shutdown is designed to occur at a junction temperature of approximately 150°C. The receiver features a minimum input impedance of 12 k $\Omega$ , an input sensitivity of ±200 mV, and a typical input hysteresis of 50 mV.

The SN65176B and SN75176B devices can be used in transmission-line applications employing the SN75172 and SN75174 quadruple differential line drivers and SN75173 and SN75175 quadruple differential line receivers.

#### 7.2 Functional Block Diagram



## 7.3 Feature Description

#### 7.3.1 Driver

The driver converts a TTL logic signal level to RS-422 and RS-485 compliant differential output. The TTL logic input, DE pin, can be used to turn the driver on and off.

#### Table 7-1. Driver Function Table<sup>(1)</sup>

| INPUT | ENABLE | DIFFERENTIAL OUTPUTS |   |  |  |  |
|-------|--------|----------------------|---|--|--|--|
| D     | DE     | А                    | В |  |  |  |
| н     | Н      | Н                    | L |  |  |  |
| L     | н      | L                    | Н |  |  |  |
| ×     | L      | Z                    | Z |  |  |  |

(1) H = high level,

L = low level,

X = irrelevant,

Z = high impedance (off)



#### 7.3.2 Receiver

The receiver converts a RS-422 or RS-485 differential input voltage to a TTL logic level output. The TTL logic input,  $\overline{RE}$  pin, can be used to turn the receiver logic output on and off.

| DIFFERENTIAL INPUTS<br>A–B                              | ENABLE<br>RE | OUTPUT<br>R |  |  |  |  |  |  |  |  |  |
|---|--------------|-------------|--|--|--|--|--|--|--|--|--|
| V <sub>ID</sub> ≥ 0.2 V                                 | L            | Н           |  |  |  |  |  |  |  |  |  |
| $-0.2 \text{ V} < \text{V}_{\text{ID}} < 0.2 \text{ V}$ | L            | U           |  |  |  |  |  |  |  |  |  |
| $V_{ID} \leq -0.2 V$                                    | L            | L           |  |  |  |  |  |  |  |  |  |
| x   | н            | Z           |  |  |  |  |  |  |  |  |  |
| Open  | L            | U           |  |  |  |  |  |  |  |  |  |

(1) H = high level,

L = low level,

U = unknown,

Z = high impedance (off)

### 7.4 Device Functional Modes

#### 7.4.1 Device Powered

Both the driver and receiver can be individually enabled or disabled in any combination. DE and  $\overline{RE}$  can be connected together for a single port direction control bit.

#### 7.4.2 Device Unpowered

The driver differential outputs and the receiver differential inputs are connected internally to form differential input/output (I/O) bus ports that are designed to offer minimum loading to the bus when the driver is disabled or  $V_{CC} = 0$ .

#### 7.4.3 Symbol Cross Reference

| Tab                     | Table 7-3. Symbol Equivalents          |   |  |  |  |  |  |  |  |  |  |
|-------------------------|--|---|--|--|--|--|--|--|--|--|--|
| DATA SHEET<br>PARAMETER | TIA/EIA-422-B                          | TIA/EIA-485-A                                   |  |  |  |  |  |  |  |  |  |
| Vo                      | V <sub>oa</sub> , V <sub>ob</sub>      | V <sub>oa</sub> , V <sub>ob</sub>               |  |  |  |  |  |  |  |  |  |
| V <sub>OD1</sub>        | Vo                                     | Vo  |  |  |  |  |  |  |  |  |  |
| V <sub>OD2</sub>        | V <sub>t</sub> ® <sub>L</sub> = 100 Ω) | $V_t \otimes_L = 54 \Omega$                     |  |  |  |  |  |  |  |  |  |
| [V <sub>OD3</sub> ]     |  | V <sub>t</sub> (test termination measurement 2) |  |  |  |  |  |  |  |  |  |
| $\Delta  V_{OD} $       | V <sub>t</sub>   –   V̄ t              | $  V_t -  \overline{V}_t  $                     |  |  |  |  |  |  |  |  |  |
| V <sub>OC</sub>         | V <sub>os</sub>                        | V <sub>os</sub>                                 |  |  |  |  |  |  |  |  |  |
|                         | $ V_{os} - \overline{V}_{os} $         | $ V_{os} - \overline{V}_{os} $                  |  |  |  |  |  |  |  |  |  |
| I <sub>OS</sub>         | I <sub>sa</sub>  ,  I <sub>sb</sub>    |   |  |  |  |  |  |  |  |  |  |
| Ι <sub>Ο</sub>          | I <sub>xa</sub>  ,  I <sub>xb</sub>    | l <sub>ia</sub> , l <sub>ib</sub>               |  |  |  |  |  |  |  |  |  |

#### Table 7-3. Symbol Equivalents



## **8** Application and Implementation

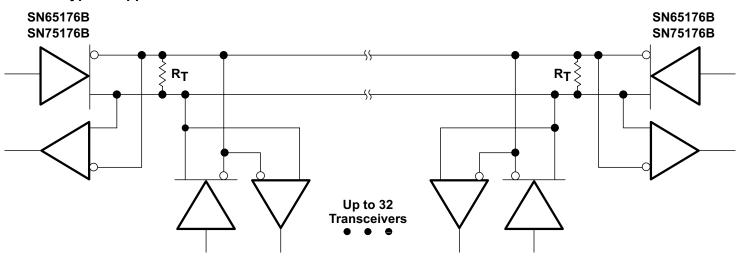
#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 8.1 Application Information

The device can be used in RS-485 and RS-422 physical layer communications.

#### **8.2 Typical Application**



The line should be terminated at both ends in its characteristic impedance  $\mathbb{B}_T = Z_0$ ). Stub lengths off the main line should be kept as short as possible.

#### Figure 8-1. Typical RS-485 Application Circuit

#### 8.2.1 Design Requirements

- 5-V power source
- RS-485 bus operating at 10 Mbps or less
- Connector that ensures the correct polarity for port pins
- External fail safe implementation
- 8.2.2 Detailed Design Procedure
- Place the device close to bus connector to keep traces (stub) short to prevent adding reflections to the bus line
- If desired, add external fail-safe biasing to ensure +200 mV on the A-B port.



#### 8.2.3 Application Curves

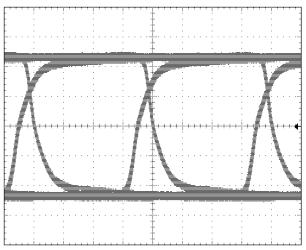


Figure 8-2. Eye Diagram for 10-Mbits/s over 100 feet of standard CAT-5E cable 120-Ω Termination at both ends. Scale is 1 V per division and 25 nS per division

## 8.3 System Examples

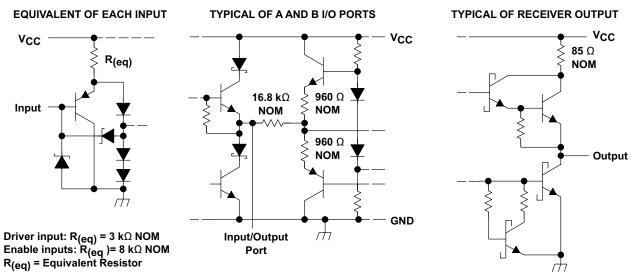


Figure 8-3. Schematics of Inputs and Outputs



## 9 Power Supply Recommendations

Power supply should be 5 V with a tolerance less than 10%

## 10 Layout

## **10.1 Layout Guidelines**

Traces from device pins A and B to connector must be short and capable of 250 mA maximum current.

### 10.2 Layout Example

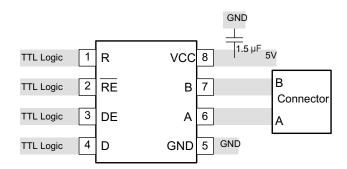


Figure 10-1. Layout Diagram



## **11 Device and Documentation Support**

## 11.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

| PARTS    | PRODUCT FOLDER      | SAMPLE & BUY | TECHNICAL<br>DOCUMENTS | TOOLS &<br>SOFTWARE | SUPPORT &<br>COMMUNITY |  |  |  |  |  |  |
|----------|---------------------|--------------|------------------------|---------------------|------------------------|--|--|--|--|--|--|
| SN65176B | Click here          | Click here   | Click here             | Click here          | Click here             |  |  |  |  |  |  |
| SN75176B | SN75176B Click here |              | Click here             | Click here          | Click here             |  |  |  |  |  |  |

#### Table 11-1. Related Links

## 11.2 Trademarks

All trademarks are the property of their respective owners.

#### **11.3 Electrostatic Discharge Caution**



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 11.4 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



## **PACKAGING INFORMATION**

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|---------|
| SN65176BD        | NRND          | SOIC         | D                  | 8    | 75             | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 105   | 65176B                  |         |
| SN65176BDG4      | NRND          | SOIC         | D                  | 8    | 75             | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 105   | 65176B                  |         |
| SN65176BDR       | ACTIVE        | SOIC         | D                  | 8    | 2500           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 105   | 65176B                  | Samples |
| SN65176BDRE4     | ACTIVE        | SOIC         | D                  | 8    | 2500           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 105   | 65176B                  | Samples |
| SN65176BDRG4     | ACTIVE        | SOIC         | D                  | 8    | 2500           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 105   | 65176B                  | Samples |
| SN65176BP        | ACTIVE        | PDIP         | Р                  | 8    | 50             | RoHS & Green    | NIPDAU                               | N / A for Pkg Type   | -40 to 105   | SN65176BP               | Samples |
| SN75176BD        | NRND          | SOIC         | D                  | 8    | 75             | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | 75176B                  |         |
| SN75176BDE4      | NRND          | SOIC         | D                  | 8    | 75             | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | 75176B                  |         |
| SN75176BDG4      | NRND          | SOIC         | D                  | 8    | 75             | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | 75176B                  |         |
| SN75176BDR       | ACTIVE        | SOIC         | D                  | 8    | 2500           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | 75176B                  | Samples |
| SN75176BDRE4     | ACTIVE        | SOIC         | D                  | 8    | 2500           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | 75176B                  | Samples |
| SN75176BDRG4     | ACTIVE        | SOIC         | D                  | 8    | 2500           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | 75176B                  | Samples |
| SN75176BP        | ACTIVE        | PDIP         | Р                  | 8    | 50             | RoHS & Green    | NIPDAU                               | N / A for Pkg Type   | 0 to 70      | SN75176BP               | Samples |
| SN75176BPE4      | ACTIVE        | PDIP         | Р                  | 8    | 50             | RoHS & Green    | NIPDAU                               | N / A for Pkg Type   | 0 to 70      | SN75176BP               | Samples |
| SN75176BPSR      | ACTIVE        | SO           | PS                 | 8    | 2000           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | A176B                   | Samples |
| SN75176BPSRG4    | ACTIVE        | SO           | PS                 | 8    | 2000           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | A176B                   | Samples |

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".



#### www.ti.com

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption. **Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

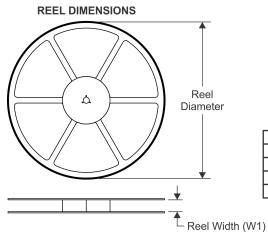
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

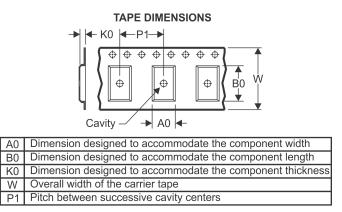
# PACKAGE MATERIALS INFORMATION

Texas Instruments

www.ti.com

## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



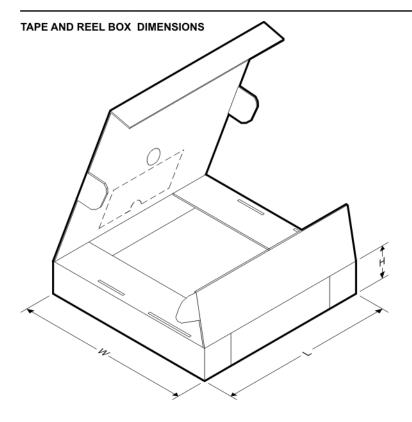
| *All dimensions are nominal |                 |                    |   |      |                          |                          |            |            |            |            |           |                  |
|-----------------------------|-----------------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device                      | Package<br>Type | Package<br>Drawing |   | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
| SN65176BDR                  | SOIC            | D                  | 8 | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| SN65176BDR                  | SOIC            | D                  | 8 | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| SN65176BDRG4                | SOIC            | D                  | 8 | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| SN75176BDR                  | SOIC            | D                  | 8 | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| SN75176BDR                  | SOIC            | D                  | 8 | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| SN75176BDRG4                | SOIC            | D                  | 8 | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| SN75176BPSR                 | SO              | PS                 | 8 | 2000 | 330.0                    | 16.4                     | 8.35       | 6.6        | 2.4        | 12.0       | 16.0      | Q1               |



www.ti.com

# PACKAGE MATERIALS INFORMATION

4-Dec-2021



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN65176BDR   | SOIC         | D               | 8    | 2500 | 340.5       | 336.1      | 25.0        |
| SN65176BDR   | SOIC         | D               | 8    | 2500 | 340.5       | 338.1      | 20.6        |
| SN65176BDRG4 | SOIC         | D               | 8    | 2500 | 340.5       | 336.1      | 25.0        |
| SN75176BDR   | SOIC         | D               | 8    | 2500 | 340.5       | 338.1      | 20.6        |
| SN75176BDR   | SOIC         | D               | 8    | 2500 | 340.5       | 336.1      | 25.0        |
| SN75176BDRG4 | SOIC         | D               | 8    | 2500 | 340.5       | 336.1      | 25.0        |
| SN75176BPSR  | SO           | PS              | 8    | 2000 | 853.0       | 449.0      | 35.0        |

P(R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE



- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001 variation BA.



# D0008A



# **PACKAGE OUTLINE**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.

- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



# D0008A

# **EXAMPLE BOARD LAYOUT**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# D0008A

# **EXAMPLE STENCIL DESIGN**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



## **MECHANICAL DATA**

## PS (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2021, Texas Instruments Incorporated